

RFID 13.56 MHz Radio Test Report

FCC ID: Q3E-XPD-R1G1

This report concerns (check one) : ⊠ Original Grant ☐ Class II Change

Issued Date : Mar. 26, 2013 Project No. : 1301060A

Equipment: Experience Payment Device

Model Name: xPD-R1G1

Applicant: Walt Disney Parks and Resorts U.S., Inc.

Address : PO Box 10000 Lake Buena Vista,

FL 32830

Tested by: Neutron Engineering Inc. EMC Laboratory

Date of Receipt: Feb. 21, 2013

Date of Test: Feb. 21, 2013 ~ Mar. 08, 2013

Testing Engineer:

(Rush Kao)

Technical Manager:

(Jen Yang

Authorized Signatory:

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Declaration

Neutron represents to the client that testing is done in accordance with standard procedures as applicable and that test instruments used has been calibrated with the standards traceable to National Measurement Laboratory (**NML**) of **R.O.C.**, or National Institute of Standards and Technology (**NIST**) of **U.S.A.**

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Limitation

For the use of the authority's logo is limited unless the Test Standard(s)/Scope(s)/Item(s) mentioned in this test report is (are) included in the conformity assessment authorities acceptance respective.

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REPORT ISSUED HISTORY

Revised Version No.	Description	Issued Date
-	Initial Issue.	Mar. 26, 2013

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1 CERTIFICATION

Equipment: Experience Payment Device

Brand Name: N/A

Model Name: xPD-R1G1

Applicant: Walt Disney Parks and Resorts U.S., Inc.

Date of Test: Feb. 21, 2013 ~ Mar. 08, 2013 Standards: FCC Part 15, Subpart C: 2012

ANSI C63.4: 2009

The above equipment has been tested and found compliance with the requirement of the relative standards by Neutron Engineering Inc. EMC Laboratory.

The test data, data evaluation, and equipment configuration contained in our test report (Ref No. NEI-FCCP-1-1301060A) were obtained utilizing the test procedures, test instruments, test sites that has been accredited by the Authority of NVLAP and TAF according to the ISO-17025 quality assessment standard and technical standard(s).

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2 SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

Standard Section	Test Item	Result
15.207	Conducted emission	N/A
15.35 / 15.205 / 15.209 / 15.225	Radiated emission	PASS
15.225(e)	Frequency Stability	PASS
15.203	Antenna Requirement	PASS

NOTE:

- N/A: denotes test is not applicable in this Test Report
 Portable device; SAR report is required.

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2.1 TEST FACILITY

The test facilities used to collect the test data in this report:

Radiated emission Test:

CB08: (FCC RN: 614388; FCC DN: TW1054; IC Assigned Code: 4428C-1) 1F., No. 61, Ln. 77, Sing-ai Rd., Neihu Dist., Taipei City 114, Taiwan (R.O.C.)

2.2 MEASUREMENT UNCERTAINTY

The measurement uncertainty is not specified by FCC rules and for reference only.

The reported uncertainty of measurement $\mathbf{y} \pm \mathbf{U}$, where expended uncertainty \mathbf{U} is based on a standard uncertainty multiplied by a coverage factor of $\mathbf{k=2}$, providing a level of confidence of approximately 95%.

The measurement instrumentation uncertainty considerations contained in CISPR 16-4-2.

Radiated emission test:

Test Site	Item	Measurement	Frequency Range	Uncertainty	NOTE
	Radiated emission at 3m		30 - 200MHz	3.35 dB	
			200 - 1000MHz	3.11 dB	
			1 - 18GHz	3.97 dB	
CB08			18 - 40GHz	4.01 dB	
CBUO			30 - 200MHz	3.22 dB	
			200 - 1000MHz	3.24 dB	
			1 - 18GHz	4.05 dB	
			18 - 40GHz	4.04 dB	

Our calculated Measurement Instrumentation Uncertainty is shown in the tables above. These are our U_{lab} values in CISPR 16-4-2 terminology.

Since Table 1 of CISPR 16-4-2 has values of measurement instrumentation uncertainty, called U_{CISPR} , as follows:

Conducted Disturbance (mains port) - 150 kHz - 30 MHz : 3.6 dB

Radiated Disturbance (electric field strength on an open area test site or alternative test site) – 30 MHz – 1000 MHz : 5.2 dB

It can be seen that our U_{lab} values are smaller than U_{CISPR} .

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3 GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

Equipment	Experience Payment Device			
Brand Name	N/A			
Model Name	xPD-R1G1			
OEM Brand/Model Name	N/A			
Model Difference	N/A			
Product Description	The EUT is an Experience Payment Device. Operation Frequency: 13.56 MHz Antenna Designation: LOOP Antenna Based on the application, features, or specification exhibited in User's Manual, the EUT is considered as an ITE/Computing Device. More details of EUT technical specification, please refer to the User's Manual.			
Power Source	DC Voltage supplied from System.			
Power Rating	I/P: DC 5V			
Connecting I/O Port(s)	Please refer to the User's Manual			
Products Covered	N/A			
EUT Modification(s) N/A				

Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

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3.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Test Mode	Description
Mode 1	Transmit

	Radiated emission test
Final Test Mode	Description
Mode 1	Transmit

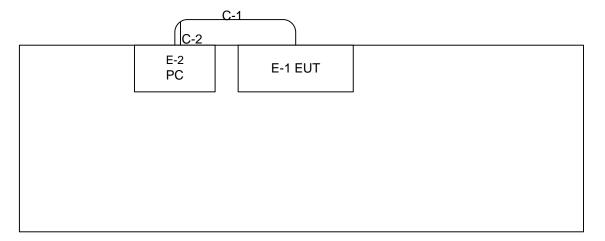
	Frequency Stability test
Final Test Mode	Description
Mode 1	Transmit

	Antenna Requirement test
Final Test Mode	Description
Mode 1	Transmit

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3.3 BLOCK DIAGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED



C-1 DATA Cable C-2 DATA Cable

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3.4 DESCRIPTION OF SUPPORT UNITS

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Mfr/Brand	Model/Type No.	FCC ID	Series No.	Note
E-1	Experience Payment Device	N/A	xPD-R1G1	Q3E-XPD-R1G1	N/A	EUT
E-2	PC	N/A	N/A	N/A	N/A	

Item	Shielded Type	Ferrite Core	Length	Note
C-1	YES	NO	1.75m	
C-2	YES	NO	0.3m	

Note:

(1) The support equipment was authorized by Declaration of Conformity (DOC).

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4 RADIATED EMISSION

4.1 LIMITS

FCC Part 15.209						
Frequency	Field Strength Limitation		Field Strength Limitation at 3m Measurement Dist			
(MHz)	(uV/m)	Dist	(uV/m)	(dBuV/m)		
0.009 - 0.490	2400 / F(KHz)	300m	10000 * 2400/F(KHz)	20log 2400/F(KHz) + 80		
0.490 - 1.705	24000 / F(KHz)	30m	100 * 24000/F(KHz)	20log 24000/F(KHz) + 40		
1.705 – 30.00	30	30m	100* 30	20log 30 + 40		
30.0 – 88.0	100	3m	100	20log 100		
88.0 – 216.0	150	3m	150	20log 150		
216.0 – 960.0	200	3m	200	20log 200		
Above 960.0	500	3m	500	20log 500		
		FCC P	art 15.225(a)/(b)/(c)			
Frequency	Field Streng Limitation		Field Strength Limitation	n at 3m Measurement Dist		
(MHz)	(uV/m)	Dist	(uV/m)	(dBuV/m)		
13.553 – 13.567	15,848	30 m	15,848*100	124		
13.567 – 13.710	334	30 m	334*100	90.5		
13.110 – 13.410 13.710 – 14.010 106 30 m		106*100	80.5			

NOTE:

- (1) The tighter limit shall apply at the boundary between two frequency range.
- (2) Limitation expressed in dBuV/m is calculated by 20log Emission Level (uV/m).
- (3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $L_{d1} = L_{d2} * (d_2/d_1)^2$.

Example:

F.S Limit at 30m distance is 30uV/m , then F.S Limitation at 3m distance is adjusted as $L_{d1}=L_1=30uV/m^* (10)^2=100^* 30 \ uV/m$

(4) The test result calculated as following:

Measurement Value = Reading Level + Correct Factor

Correct Factor = Insertion Loss + Cable Loss + Attenuator Factor(if use)

Margin Level = Measurement Value - Limit Value

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4.2 MEASUREMENT INSTRUMENTS LIST

Item	Kind of Equipment Manufactu		Type No.	Serial No.	Calibrated until
1	Spectrum Analyzer R&S		FSP-40	100129	Oct. 01, 2013
2	Microflex Cable	N/A	N/A	1m	Apr. 14, 2013
3	Test Cable	N/A	LMR-400	966_12m	May. 15, 2013
4	Test Cable	N/A	LMR-400	966_3m	May. 15, 2013
5	Pre-Amplifier	EMC	EMC-330	980088	Jun. 07, 2013
6	Log-Bicon Antenna	Schwarzbeck	VULB9168-352	9168-352	Jun. 12, 2013
7	Loop Ant.	EMCO	6502	00042960	Jul. 25, 2013

Remark: "N/A" denotes No Model Name, No Serial No. or No Calibration specified.

4.3 TEST PROCEDURE

- a. The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- b. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3m or 10 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- c. The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. The initial step in collecting radiated emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- e. If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- f. For the actual test configuration, please refer to the related Item –EUT Test Photos.

NOTE: (FCC PART 15.209)

- a. Reading in which marked as QP or Peak means measurements by using are Quasi-Peak Mode with Detector BW=120 kHz.
- b. All readings are Peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform.

NOTE: (FCC PART 15.225)

- a. Spectrum Setting:
 - 9 KHz 150 KHz, RBW= 200Hz, VBW=200Hz, Sweep time = 200 ms.
 - 150 K Hz 30 MHz, RBW= 10 KHz, VBW=10 KHz, Sweep time = 200 ms.
 - 30 MHz 1000 MHz, RBW= 100KHz, VBW=100KHz, Sweep time = 200 ms.
- b. All readings are Peak unless otherwise stated QP in column of Note. Peak denotes that the Peak reading compliance with the QP Limits and then QP Mode measurement didn't perform.
- c. The Log-Bicon Antenna will use to test frequency range from 30MHz to 1000MHz and the Loop Antenna will use to test frequency below 30MHz.

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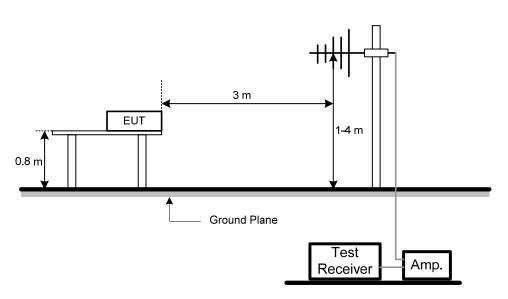


4.4 DEVIATION FROM TEST STANDARD

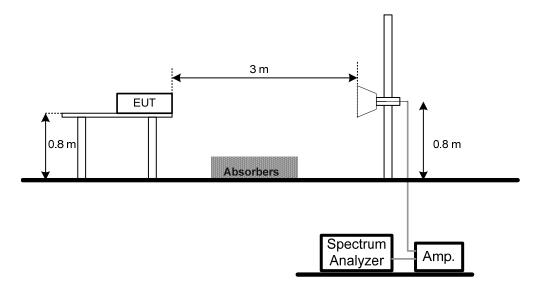
No deviation

4.5 TEST SETUP

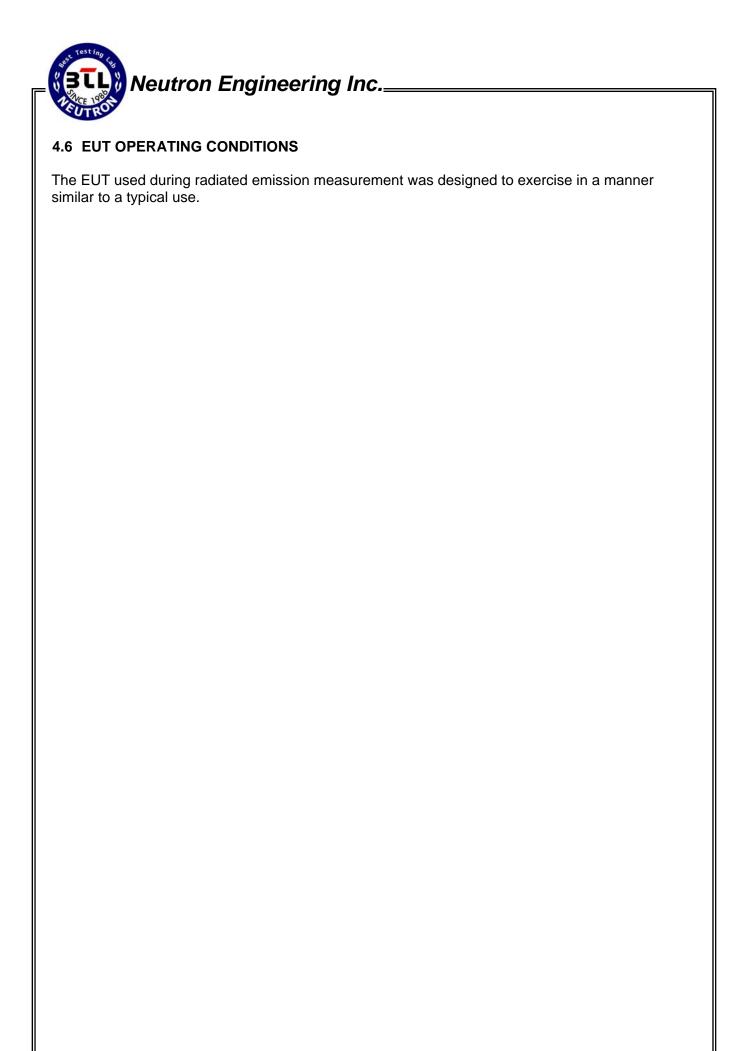
Below 1 GHz



Above 1 GHz



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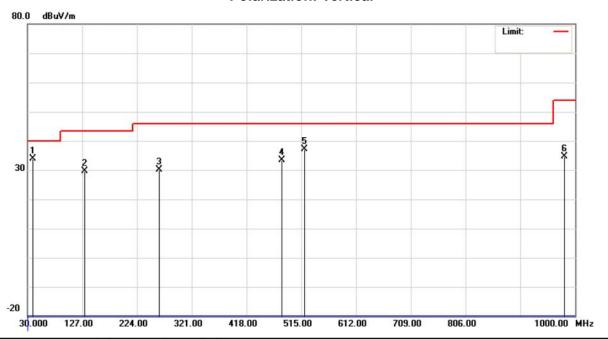


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4.7 TEST RESULTS- FCC PART 15.209

E.U.T	Experience Payment Device	Model Name	xPD-R1G1				
Temperature	26°C	Relative Humidity	60%				
Test Voltage	AC 120V/60Hz (System)						
Test Mode	Transmit						

Polarization: Vertical

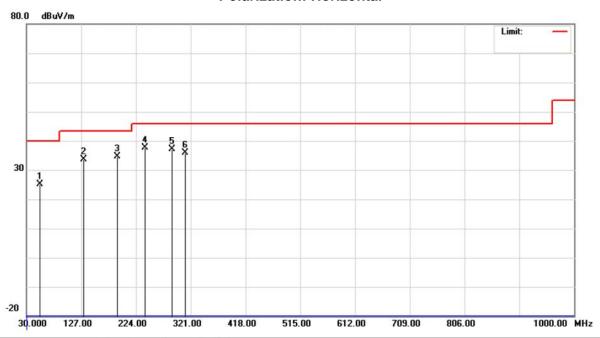


No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment
1	*	39.7000	61.72	-27.89	33.83	40.00	-6.17	peak	
2		130.8800	61.40	-31.84	29.56	43.50	-13.94	peak	
3		262.7999	60.09	-29.88	30.21	46.00	-15.79	peak	
4		480.0799	53.47	-20.13	33.34	46.00	-12.66	peak	
5		520.8200	55.96	-18.77	37.19	46.00	-8.81	peak	
6		980.5999	42.62	-7.97	34.65	54.00	-19.35	peak	

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E.U.T	Experience Payment Device	Model Name	xPD-R1G1
Temperature	26°C	Relative Humidity	60%
Test Voltage	AC 120V/60Hz (System)		
Test Mode	Transmit		

Polarization: Horizontal

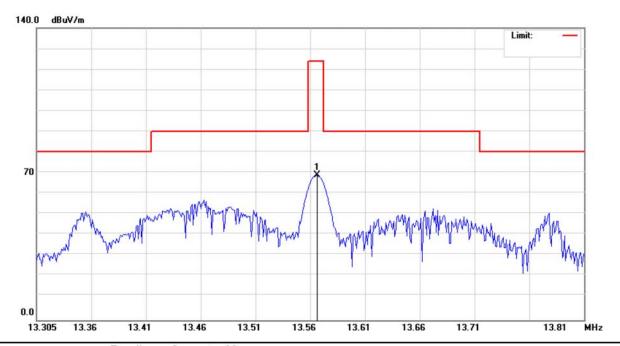


No.	Mk	. Freq.	Level	Factor	ment	Limit	Over			
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment	
1		53.2800	51.23	-26.21	25.02	40.00	-14.98	peak		
2		130.8800	57.84	-24.27	33.57	43.50	-9.93	peak		
3		191.0200	59.35	-24.84	34.51	43.50	-8.99	peak		
4	*	239.5200	61.19	-23.47	37.72	46.00	-8.28	peak		
5		288.0200	62.58	-25.33	37.25	46.00	-8.75	peak		
6		311.3000	63.53	-27.54	35.99	46.00	-10.01	peak		

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4.8 TEST RESULTS- FCC PART 15.225

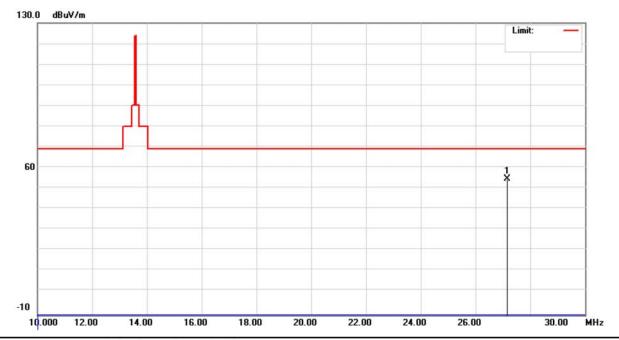
E.U.T	Experience Payment Device	Model Name	xPD-R1G1			
Temperature	26°C	Relative Humidity	60%			
Test Voltage	AC 120V/60Hz (System)					
Test Mode	Transmit					



No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment	
1	*	13.5610	58.07	11.24	69.31	124.0	-54.69	peak		

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E.U.T	Experience Payment Device	Model Name	xPD-R1G1			
Temperature	26°C	Relative Humidity	60%			
Test Voltage	AC 120V/60Hz (System)					
Test Mode	Transmit					



No.	Mk	. Freq.		Correct Factor	Measure- ment	Limit	Over			
		MHz	MHz dBuV	dB dBuV/m	dBuV/m	dBuV/m	n dB	Detector	Comment	
1	*	27.1600	45.25	9.91	55.16	69.54	-14.38	peak		

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5 FREQUENCY STABILITY

5.1 LIMITS

FCC Part 15.225(e)

The frequency tolerance of the carrier signal shall be maintained within +/-0.01% of the operating frequency over a temperature variation of - 20 degrees to + 50 degrees C at normal supply voltage, and for a variation in the primary supply voltage from 85% to 115% of the rated supply voltage at a temperature of 20 degrees C.

For battery operated equipment, the equipment tests shall be performed using a new battery.

5.2 MEASUREMENT INSTRUMENTS LIST

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Spectrum Analyzer	R&S	FSP-40	100129	Oct. 01, 2013

Remark: "N/A" denotes No Model Name, No Serial No. or No Calibration specified.

5.3 TEST PROCEDURE

- a. The equipment under test was connected to an external AC power supply and the RF output was connected to a frequency counter via feed through attenuators. The EUT was placed inside the temperature chamber.
 - After the temperature stabilized for approximately 20 minutes, the frequency of the output signal was recorded from the counter.
- b. At room temperature (25±5°C), an external variable AC power supply was connected to the EUT. The frequency of the transmitter was measured for 115%, 100% and 85% of the nominal operating input voltage.

5.4 DEVIATION FROM TEST STANDARD

No deviation

5.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of **4.1.6** Unless otherwise a special operating condition is specified in the follows during the testing.

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5.6 TEST RESULTS

E.U.T	Experience Payment Device	Model Name	xPD-R1G1
Temperature	26°C	Relative Humidity	60%
Test Voltage	AC 120V/60Hz (System)		
Test Mode	Transmit		

	Frequency Stability Versus Environmental Temperature										
	Temperature (°C)	Voltage (AC)	Frequency (MHz)	Frequency Error (kHz)	Limit (kHz)	Result					
	20	120V	13.56084								
0 min	50	120V	13.56084	0.000	+/- 1.356	PASS					
	-20	120V	13.56920	8.360	+/- 1.356	PASS					
2 min	50	120V	13.56084	0.000	+/- 1.356	PASS					
	-20	120V	13.56088	0.040	+/- 1.356	PASS					
5 min	50	120V	13.56084	0.000	+/- 1.356	PASS					
	-20	120V	13.56088	0.040	+/- 1.356	PASS					
10 min	50	120V	13.56088	0.040	+/- 1.356	PASS					
	-20	120V	13.56092	0.080	+/- 1.356	PASS					

Fuequency Stability Versus Input Voltage						
Temperature (°C)	Voltage (AC)		Frequency (MHz)	Frequency Error (kHz)	Limit (kHz)	Result
20	V-nom	120	13.56084			
20	V-min	102	13.56088	0.04	+/- 1.356	PASS
20	V-max	138	13.56088	0.04	+/- 1.356	PASS

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